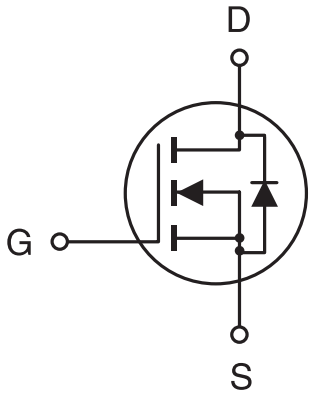
CET3055

March 1998

N-Channel Enhancement Mode Field Effect Transistor

FEATURES

- 60V , 4A , $R_{DS(ON)}$=100mΩ @V_{GS}=10V.
- High dense cell design for low $R_{DS(ON)}$.
- Rugged and reliable.
- SOT-223 Package.



SOT-223

SOT-223 (J23Z)

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ABSOLUTE MAXIMUM RATINGS (T_A=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	±20	V
Drain Current-Continuous[a] @T_J=125°C	I_D	±4	A
-Pulsed[b]	I_{DM}	±25	A
Drain-Source Diode Forward Current[a]	I_S	2.5	A
Maximum Power Dissipation[a]	P_D	3	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-65 to 150	°C

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient[a]	$R_{\theta JA}$	42	°C/W

ELECTRICAL CHARACTERISTICS (T_A=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} = 0V, I_D = 250μA	60			V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 48V, V_{GS} = 0V			10	μA
Gate-Body Leakage	I_{GSS}	V_{GS} = ±20V, V_{DS} = 0V			±100	nA
ON CHARACTERISTICS[b]						
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250μA	2	2.7	4	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	V_{GS} = 10V, I_D = 4A		75	100	mΩ
On-State Drain Current	$I_{D(ON)}$	V_{DS} = 10V, V_{GS} = 10V	15			A
Forward Transconductance	g_{FS}	V_{DS} = 15V, I_D = 4A	3	4		S
DYNAMIC CHARACTERISTICS[c]						
Input Capacitance	C_{ISS}	V_{DS} = 25V, V_{GS} = 0V f = 1.0MHz		292	400	pF
Output Capacitance	C_{OSS}			130	200	pF
Reverse Transfer Capacitance	C_{RSS}			36	50	pF
SWITCHING CHARACTERISTICS[c]						
Turn-On Delay Time	$t_{D(ON)}$	V_{DD} = 25V, I_D = 1.2A, V_{GS}= 10V, R_{GEN} = 50Ω		17	25	ns
Rise Time	t_r			24	50	ns
Turn-Off Delay Time	$t_{D(OFF)}$			41	65	ns
Fall time	t_f			33	60	ns
Total Gate Charge	Q_g	V_{DS} = 40V, I_D =4A, V_{GS} = 10V		9	17	nC
Gate-Source Charge	Q_{gs}			3		nC
Gate-Drain Charge	Q_{gd}			3		nC

CET3055

ELECTRICAL CHARACTERISTICS (T_A=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS [b]						
Diode Forward Voltage	V_{SD}	V_{GS} = 0V, Is =4A			1.2	V

Notes

a.Surface Mounted on FR4 Board, t ≤10sec.

b.Pulse Test:Pulse Width ≤300 μs, Duty Cycle ≤2%.

c.Guaranteed by design, not subject to production testing.

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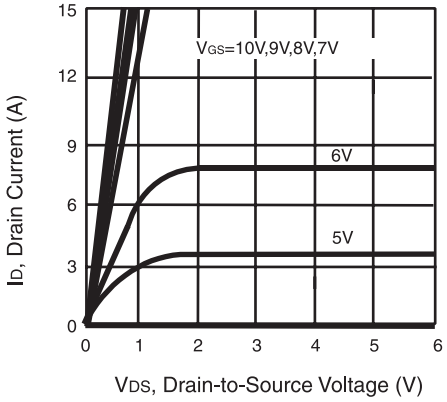

Figure 1. Output Characteristics

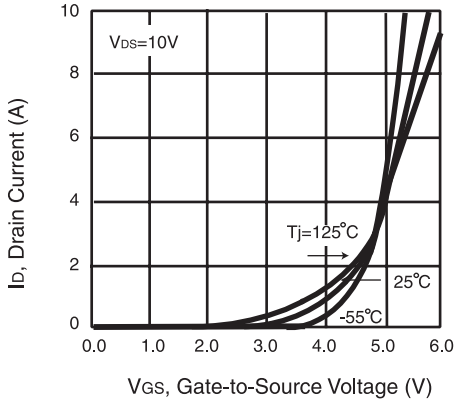

Figure 2. Transfer Characteristics

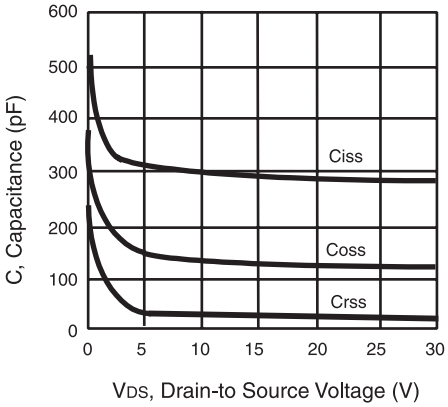

Figure 3. Capacitance

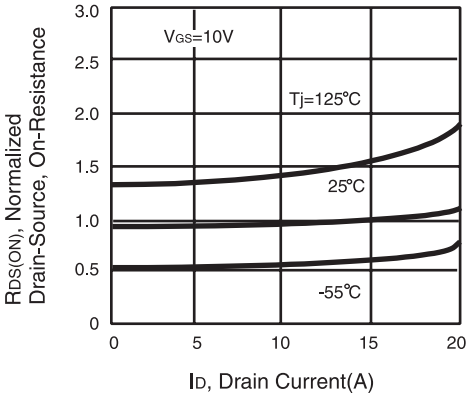

Figure 4. On-Resistance Variation with Drain Current and Temperature

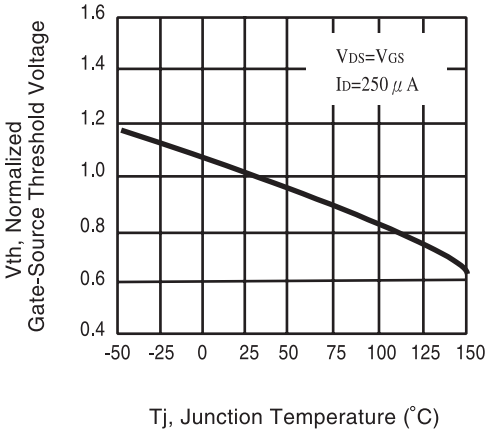

Figure 5. Gate Threshold Variation with Temperature

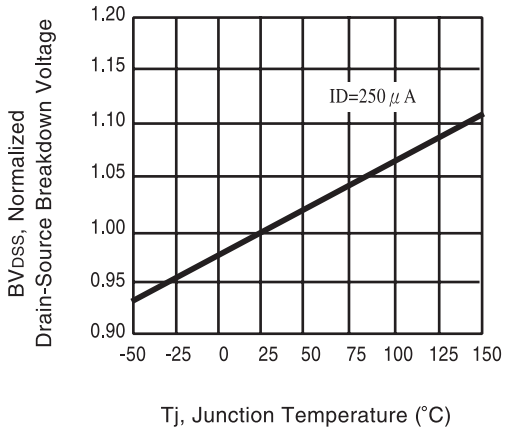

Figure 6. Breakdown Voltage Variation with Temperature

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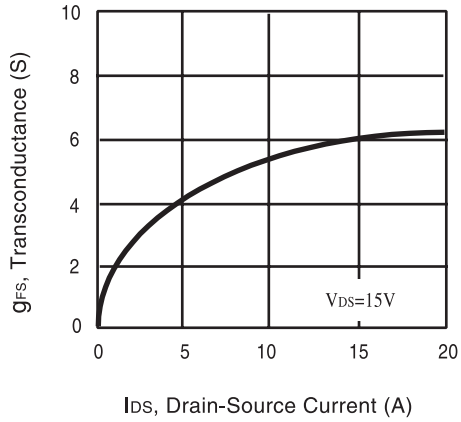

Figure 7. Transconductance Variation with Drain Current

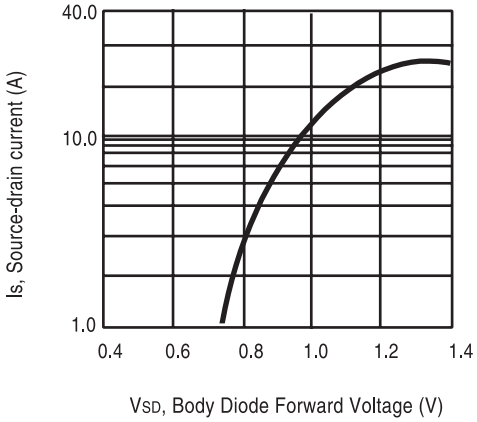

Figure 8. Body Diode Forward Voltage Variation with Source Current

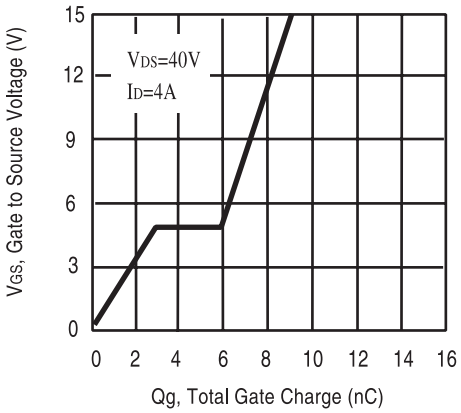

Figure 9. Gate Charge

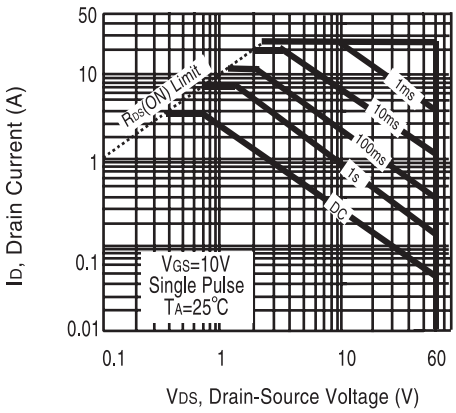

Figure 10. Maximum Safe Operating Area

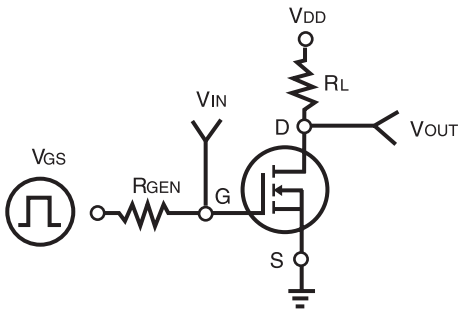

Figure 11. Switching Test Circuit

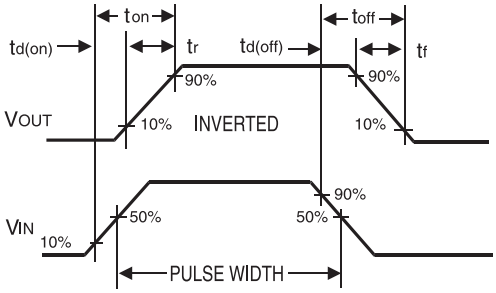

Figure 12. Switching Waveforms

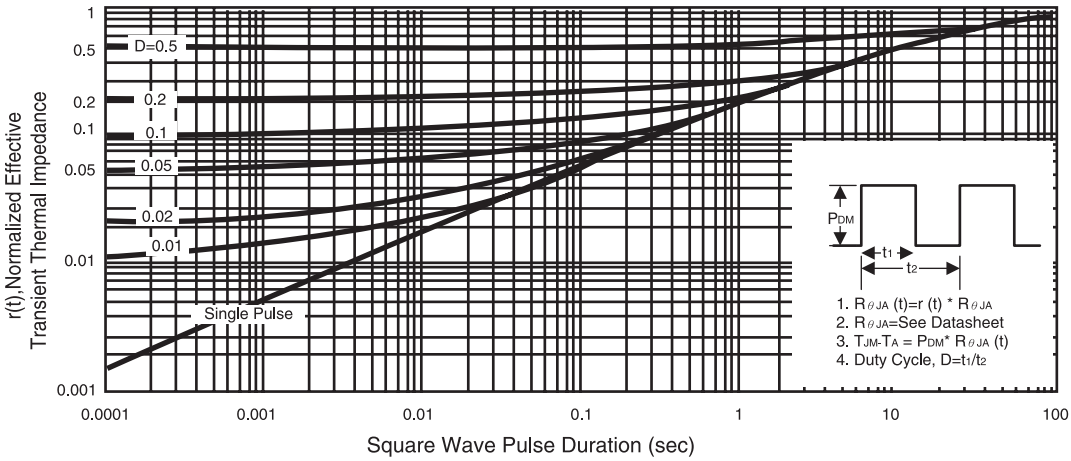

Figure 13. Normalized Thermal Transient Impedance Curve